



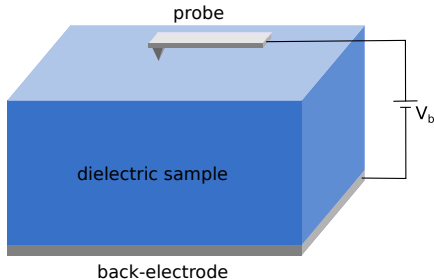
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# Multiscale method for simulating KPFM

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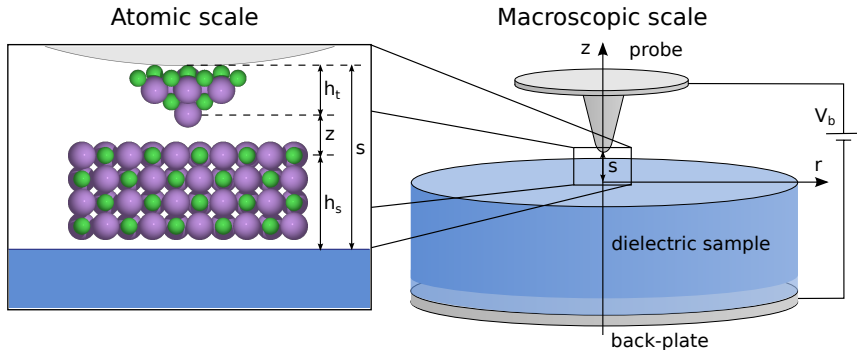
September 2, 2016

# KPFM measurement setup

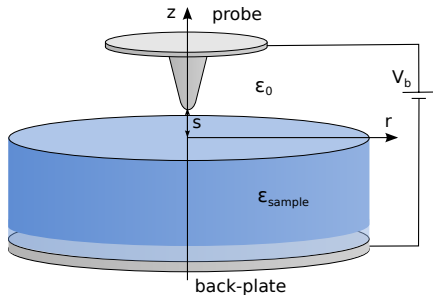


- The interesting quantity:  
 $F_{probe}(x, y, z, V)$
- Effective bias voltage:  
 $V = V_b - V_{CPD}$
- Sample is thick, considered as bulk material

# Two length scales

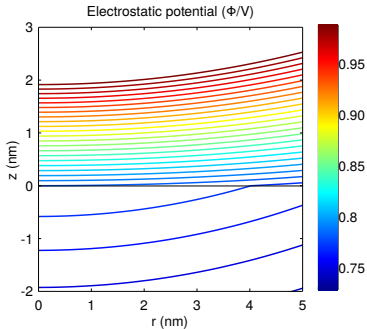
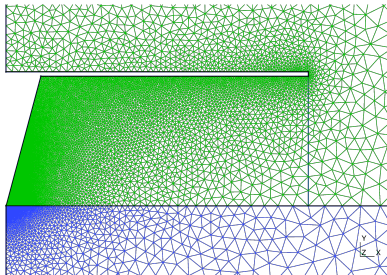


# Macroscopic model

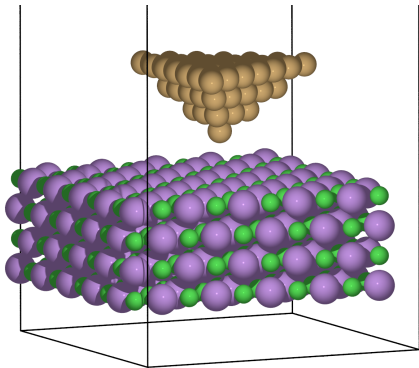


- Axisymmetric model of the probe
- Classical electrostatic boundary value problem
- Solve electrostatic potential  $\Phi(\mathbf{r})$  from generalized Poisson equation
$$\nabla \cdot [\epsilon(\mathbf{r}) \nabla \Phi(\mathbf{r})] = 0$$
- Boundary values:
$$\Phi_{\text{probe}} = V, \Phi_{\text{backplate}} = 0$$

# Solving electrostatic potential using FEM

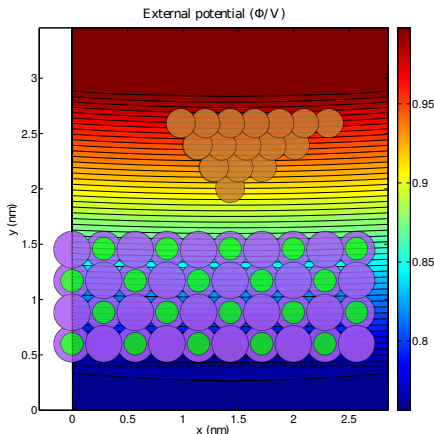


# Atomic model



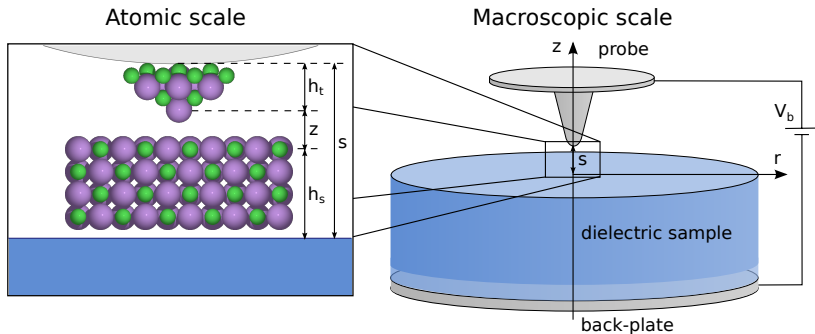
- Solve the electron density distribution using density functional theory (DFT)
- Leads to many quantities of the system, including total energy  $\rightarrow$  force on tip

# DFT with external potential



- The electrostatic potential is applied to the atomic scale DFT calculation
- The axisymmetric solution is interpolated to a 3D grid that fills the DFT unit cell
- No uniform electric field approximation

## Summary of the method



Microscopic force:

$$F_{\mu}(x, y, z, V) = a(x, y, z)V + b$$

Macroscopic force:

$$F_M(s, V) = \frac{1}{2}C'(s)V^2$$